Notice of References Cited

Application/Control No. 10/734,770	Reexamination	Applicant(s)/Patent Under Reexamination FLURRY ET AL.		
Examiner	Art Unit			
Krisna Lim	2153	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,188,155	03-2007	Flurry et al.	709/219
*	В	US-2004/0139151	07-2004	Flurry et al.	709/203
*	С	US-2005/0021663	01-2005	Knauerhase et al.	709/217
*	D	US-2002/0147887	10-2002	Copeland et al.	711/118
*	Ε	US-2002/0143819	10-2002	Han et al.	707/513
*	F	US-2003/0061404	03-2003	Atwal et al.	709/328
*	G	US-2004/0111525	06-2004	Berkland et al.	709/231
*	н	US-2004/0117425	06-2004	Berkland et al.	709/200
*	_1	US-2005/0132086	06-2005	Flurry et al.	709/238
	J	US-			
	Κ	US-			
	L	US-			
	Σ	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Q					
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	Т					

NON-PATENT DOCUMENTS

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		x			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.